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Automotive-grade dual N-channel 40 V, 8 mΩ typ., 15 A STripFET™ F5 Power MOSFET in a PowerFLAT™ 5x6 DI

Datasheet - production data

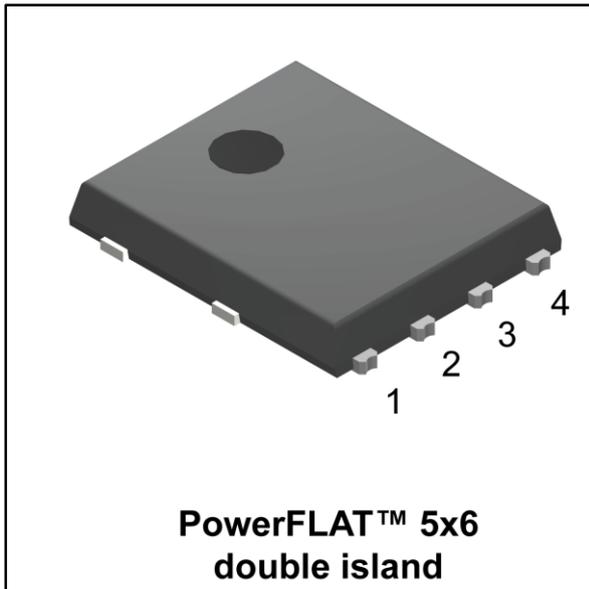


Figure 1: Internal schematic diagram

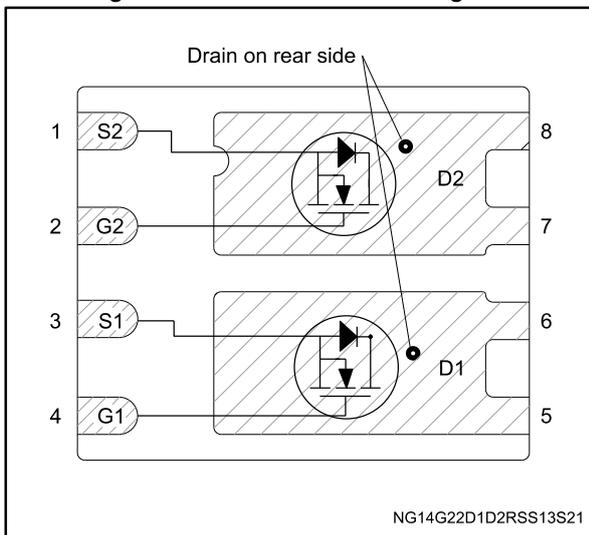


Table 1: Device summary

| Order code | Marking | Package | Packing |
|------------|---------|------------------------------|---------------|
| STL15DN4F5 | 15DN4F5 | PowerFLAT™ 5x6 double island | Tape and reel |

Features

| Order code | V _{DS} | R _{DS(on)} max. | I _D |
|------------|-----------------|--------------------------|----------------|
| STL15DN4F5 | 40 V | 9 mΩ | 15 A |

- Designed for automotive applications and AEC-Q101 qualified
- Extremely low R_{DS(on)}
- Very low gate charge
- Low gate drive power loss
- Wettable flank package

Applications

- Switching applications

Description

This device is a dual N-channel Power MOSFET developed using STMicroelectronics' STripFET™ F5 technology. The device has been optimized to achieve very low on-state resistance, contributing to a FoM that is among the best in its class.

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1 Electrical ratings

Table 2: Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|-------------------|---|------------|------------------|
| V_{DS} | Drain-source voltage | 40 | V |
| V_{GS} | Gate-source voltage | ± 20 | V |
| $I_D^{(1)}$ | Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$ | 60 | A |
| $I_D^{(2)}$ | Drain current (continuous) at $T_{pcb} = 25\text{ }^\circ\text{C}$ | 15 | A |
| $I_D^{(2)}$ | Drain current (continuous) at $T_{pcb} = 100\text{ }^\circ\text{C}$ | 10 | A |
| $I_{DM}^{(2)(3)}$ | Drain current (pulsed) | 60 | A |
| $P_{TOT}^{(1)}$ | Total dissipation at $T_C = 25\text{ }^\circ\text{C}$ | 60 | W |
| $P_{TOT}^{(2)}$ | Total dissipation at $T_{pcb} = 25\text{ }^\circ\text{C}$ | 4.3 | W |
| T_j | Operating junction temperature range | -55 to 175 | $^\circ\text{C}$ |
| T_{stg} | Storage temperature range | | |

Notes:

- (1)The value is rated according R_{thj-c} .
 (2)The value is rated according $R_{thj-pcb}$.
 (3)Pulse width limited by safe operating area.

Table 3: Thermal resistance

| Symbol | Parameter | Value | Unit |
|---------------------|----------------------------------|-------|---------------------------|
| $R_{thj-case}$ | Thermal resistance junction-case | 2.5 | $^\circ\text{C}/\text{W}$ |
| $R_{thj-pcb}^{(1)}$ | Thermal resistance junction-pcb | 35 | $^\circ\text{C}/\text{W}$ |

Notes:

- (1)When mounted on FR-4 board of 1 inch², 2oz Cu, $t < 10\text{ }s$.

Table 4: Avalanche data

| Symbol | Parameter | Value | Unit |
|----------------|--|-------|------|
| I_{AV} | Not-repetitive avalanche current, (pulse width limited by T_j max.) | 7.5 | A |
| $E_{AS}^{(1)}$ | Single pulse avalanche energy (starting $T_J = 25\text{ }^\circ\text{C}$, $I_D = I_{AV}$, $V_{DD} = 24\text{ V}$) | 150 | mJ |

Notes:

- (1)Tested at wafer level only.

2 Electrical characteristics

($T_C = 25\text{ }^\circ\text{C}$ unless otherwise specified)

Table 5: On/Off states

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------|-----------------------------------|--|------|------|-----------|---------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $I_D = 250\text{ }\mu\text{A}$, $V_{GS} = 0\text{ V}$ | 40 | | | V |
| I_{DSS} | Zero gate voltage drain current | $V_{GS} = 0\text{ V}$, $V_{DS} = 40\text{ V}$ | | | 1 | μA |
| | | $V_{GS} = 0\text{ V}$, $V_{DS} = 40\text{ V}$, $T_C = 125\text{ }^\circ\text{C}$ ⁽¹⁾ | | | 10 | μA |
| I_{GSS} | Gate-body leakage current | $V_{GS} = \pm 20\text{ V}$, $V_{DS} = 0\text{ V}$ | | | ± 100 | nA |
| $V_{GS(th)}$ | Gate threshold voltage | $V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{A}$ | 2 | | 4 | V |
| $R_{DS(on)}$ | Static drain-source on-resistance | $V_{GS} = 10\text{ V}$, $I_D = 7.5\text{ A}$ | | 8 | 9 | m Ω |

Notes:

⁽¹⁾Defined by design, not subject to production test

Table 6: Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------|------------------------------|---|------|------|------|------|
| C_{iss} | Input capacitance | $V_{DS} = 25\text{ V}$, $f = 1\text{ MHz}$, $V_{GS} = 0\text{ V}$ | - | 1550 | - | pF |
| C_{oss} | Output capacitance | | - | 230 | - | |
| C_{rss} | Reverse transfer capacitance | | - | 25 | - | |
| Q_g | Total gate charge | $V_{DD} = 20\text{ V}$, $I_D = 15\text{ A}$, $V_{GS} = 10\text{ V}$ (see Figure 14: "Test circuit for gate charge behavior") | - | 25 | - | nC |
| Q_{gs} | Gate-source charge | | - | 6 | - | |
| Q_{gd} | Gate-drain charge | | - | 5.5 | - | |

Table 7: Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|--------------|---------------------|--|------|------|------|------|
| $t_{d(on)}$ | Turn-on delay time | $V_{DD} = 20\text{ V}$, $I_D = 7.5\text{ A}$, $R_G = 4.7\text{ }\Omega$, $V_{GS} = 10\text{ V}$ (see Figure 13: "Test circuit for resistive load switching times") | - | 18 | - | ns |
| t_r | Rise time | | - | 45 | - | |
| $t_{d(off)}$ | Turn-off delay time | | - | 32 | - | |
| t_f | Fall time | | - | 5 | - | |

Table 8: Source-drain diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------|-------------------------------|---|------|------|------|------|
| I_{SD} | Forward on voltage | | - | | 15 | A |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) | | - | | 60 | A |
| $V_{SD}^{(2)}$ | Forward on voltage | $V_{GS} = 0, I_{SD} = 15 \text{ A}$ | - | | 1.1 | V |
| t_{rr} | Reverse recovery time | $I_{SD} = 15 \text{ A}, di/dt = 100 \text{ A}/\mu\text{s}$ | - | 30 | | ns |
| Q_{rr} | Reverse recovery charge | $V_{DD} = 32 \text{ V}, T_j = 150 \text{ }^\circ\text{C}$ (see Figure 15: "Test circuit for inductive load switching and diode recovery times") | - | 35 | | nC |
| I_{RRM} | Reverse recovery current | | - | 2.2 | | A |

Notes:

⁽¹⁾Pulse width limited by safe operating area

⁽²⁾Pulsed: pulse duration = 300 μs , duty cycle 1.5 %

2.2 Electrical characteristics (curves)

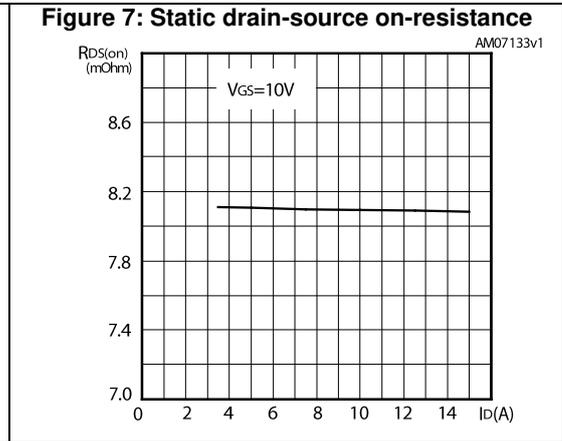
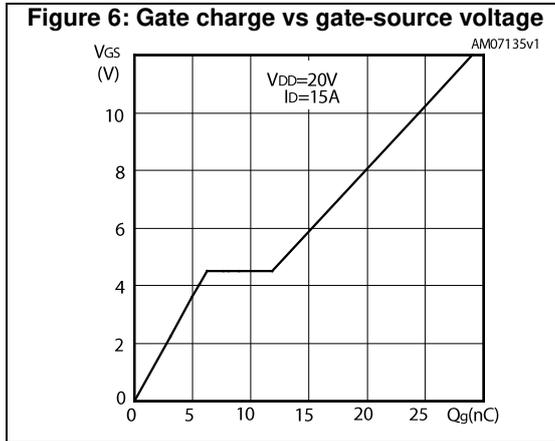
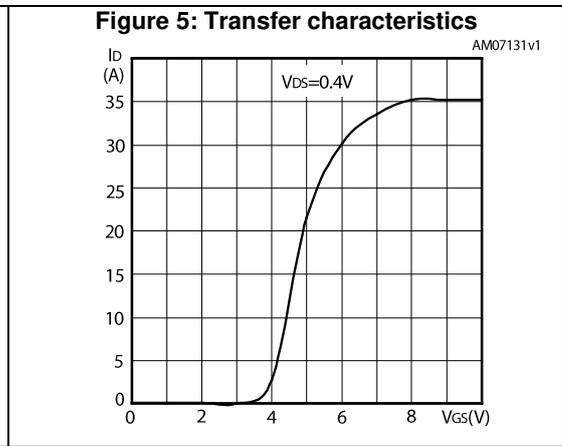
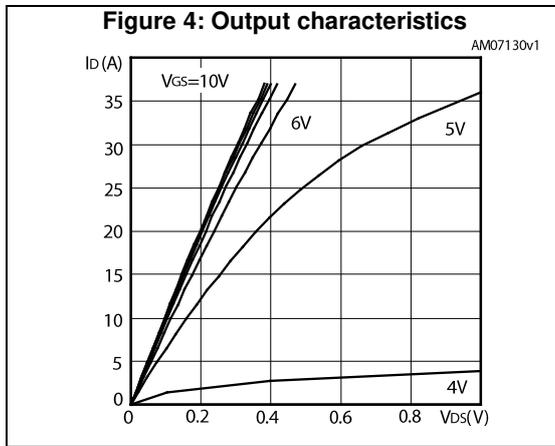
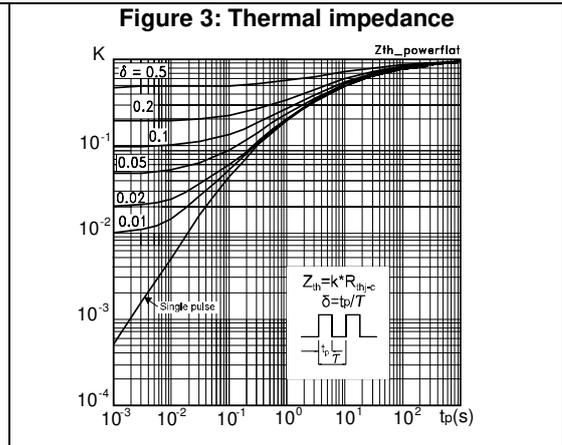
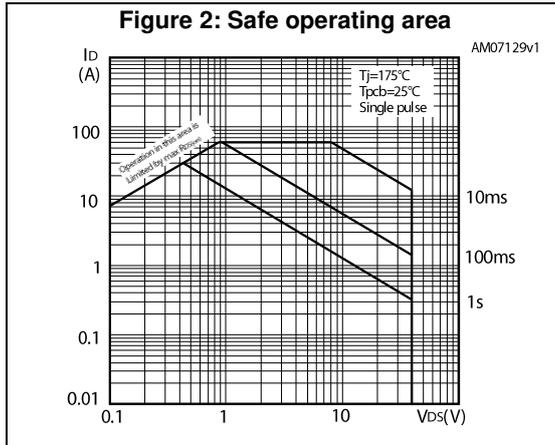


Figure 8: Capacitance variations

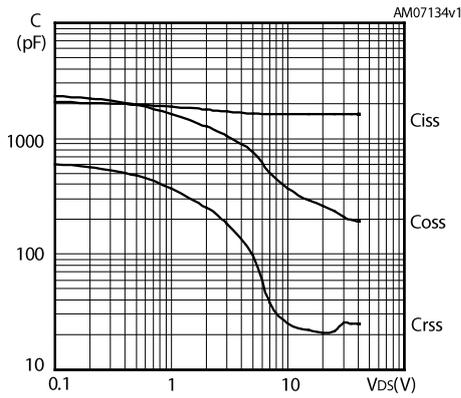


Figure 9: Normalized gate threshold voltage vs temperature

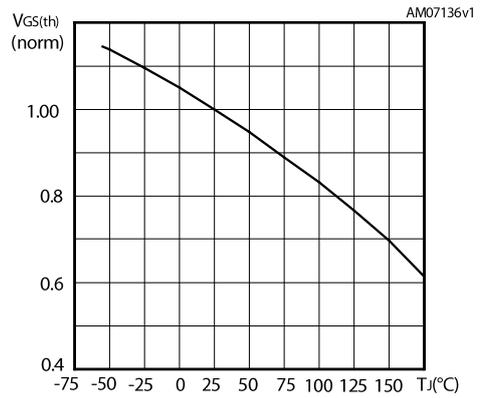


Figure 10: Normalized on-resistance vs temperature

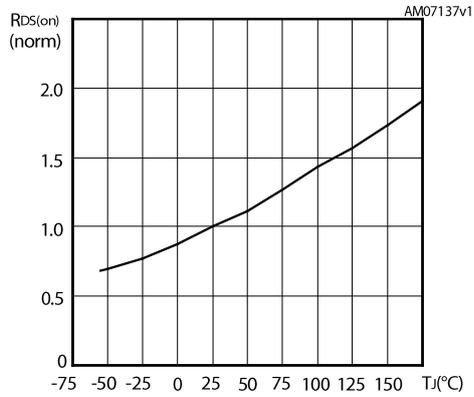


Figure 11: Normalized V(BR)DSS vs temperature

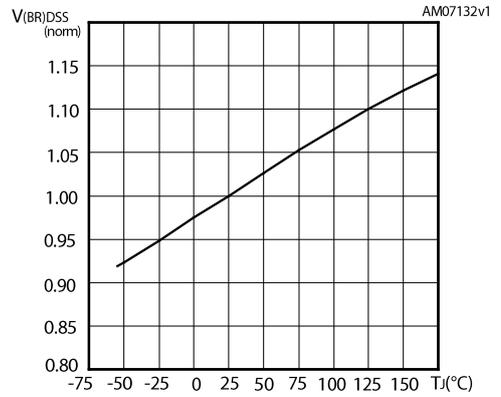
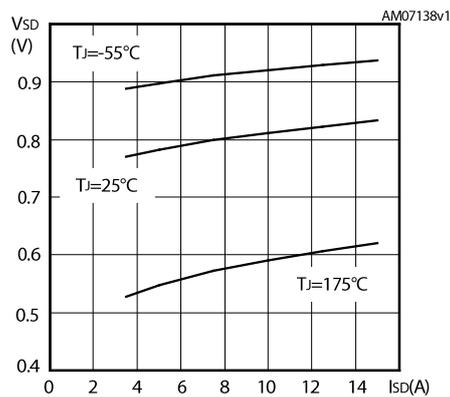
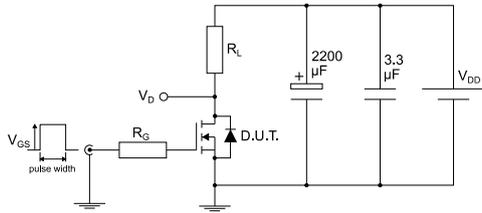


Figure 12: Source-drain diode forward characteristics



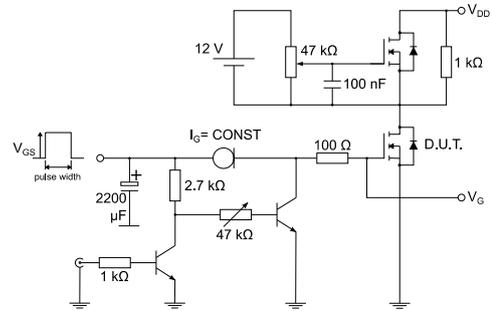
3 Test circuits

Figure 13: Test circuit for resistive load switching times



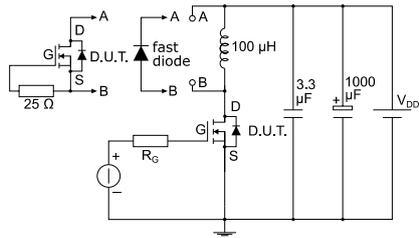
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Figure 14: Test circuit for gate charge behavior



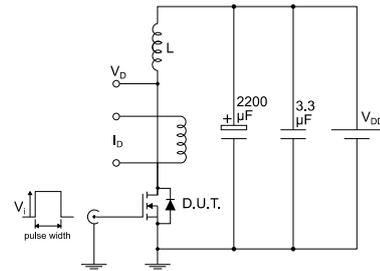
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Figure 15: Test circuit for inductive load switching and diode recovery times



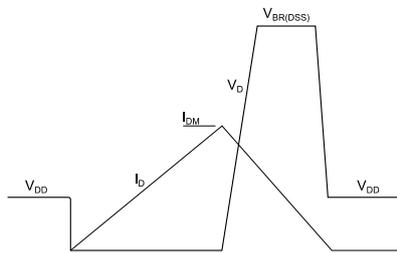
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Figure 16: Unclamped inductive load test circuit



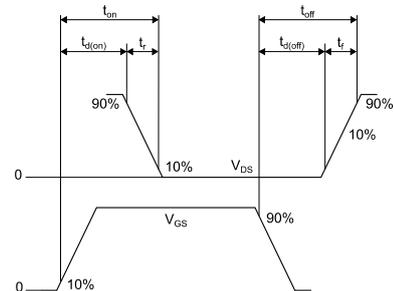
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Figure 17: Unclamped inductive waveform



AM01472v1

Figure 18: Switching time waveform



AM01473v1

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

4.1 PowerFLAT 5x6 double island WF type C package information

Figure 19: PowerFLAT™ 5x6 double island WF type C package outline

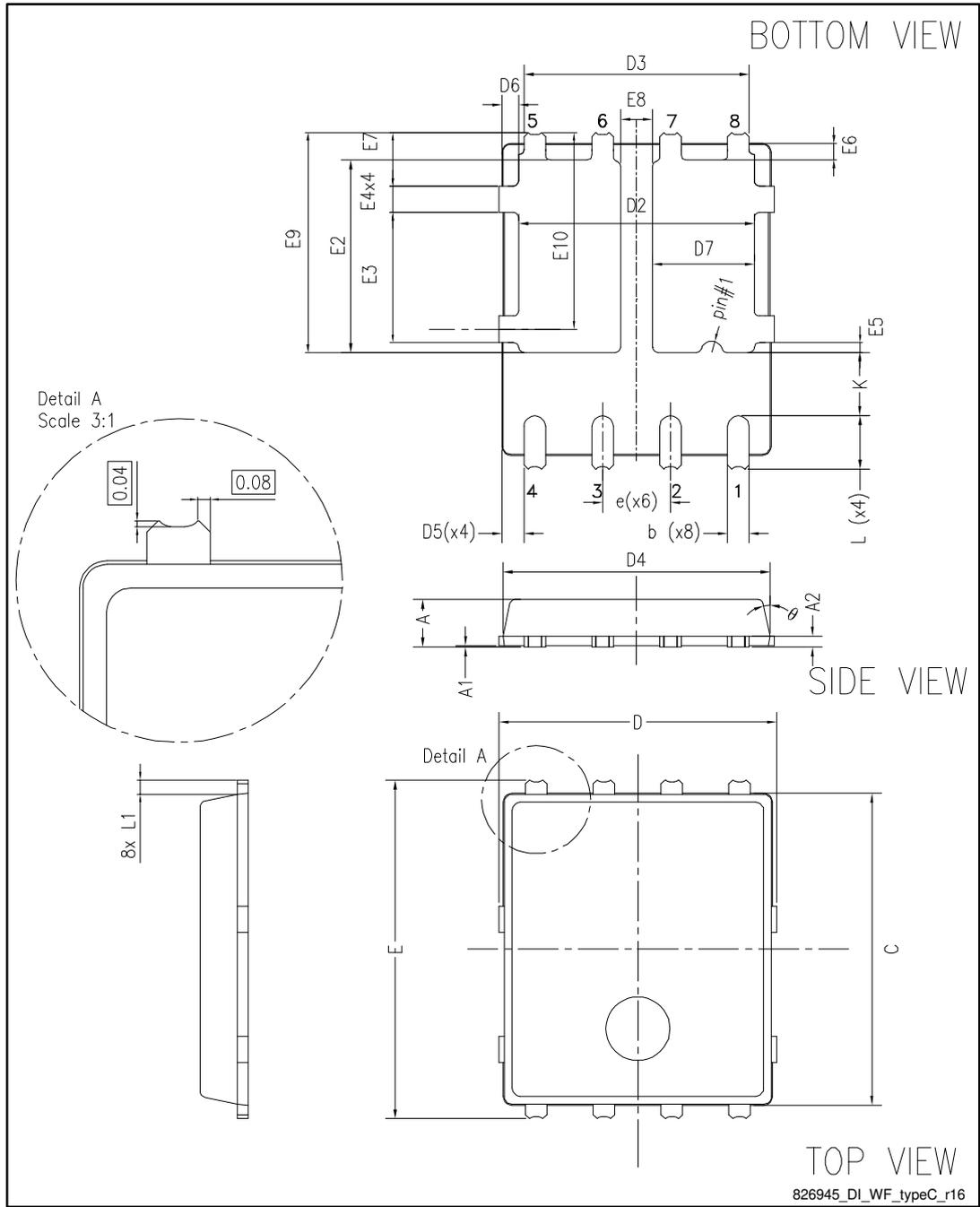
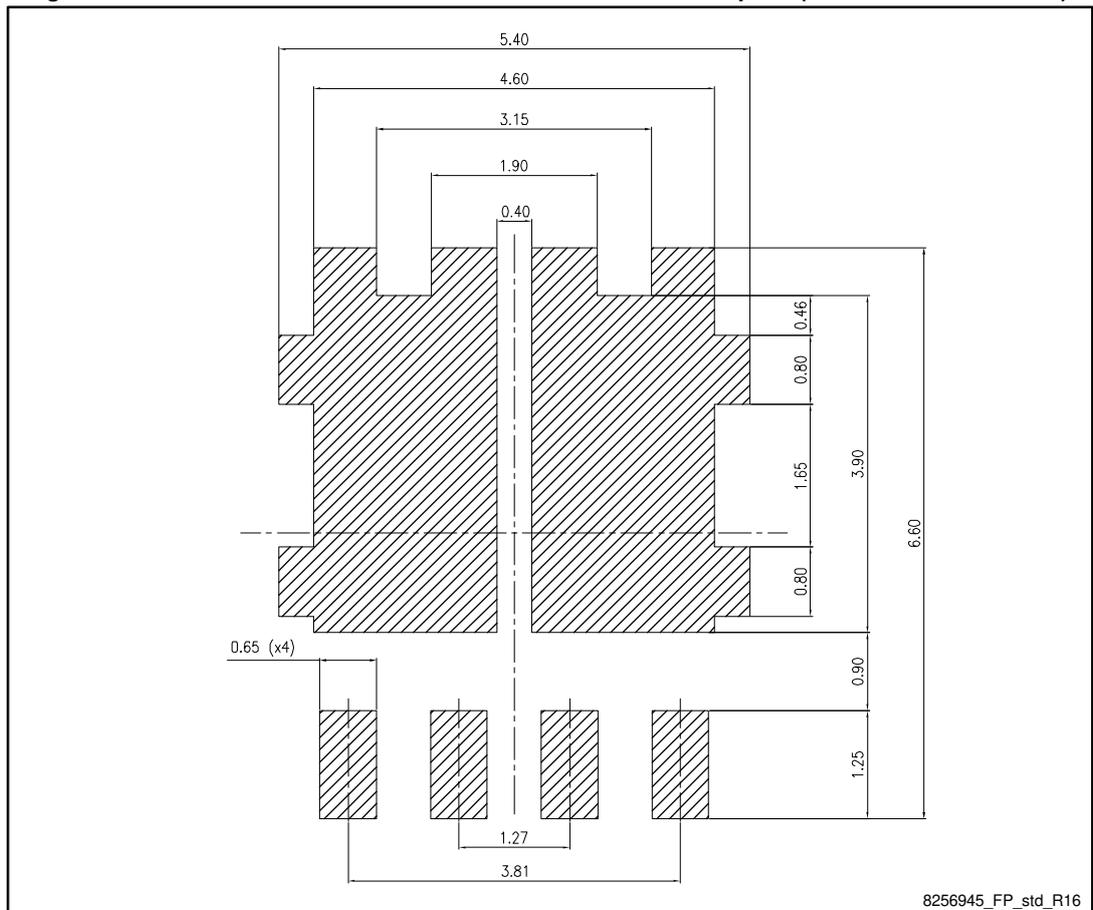


Table 9: PowerFLAT™ 5x6 double island WF type C mechanical data

| Dim. | mm | | |
|------|-------|-------|-------|
| | Min. | Typ. | Max. |
| A | 0.80 | | 1.00 |
| A1 | 0.02 | | 0.05 |
| A2 | | 0.25 | |
| b | 0.30 | | 0.50 |
| C | 5.80 | 6.00 | 6.10 |
| D | 5.00 | 5.20 | 5.40 |
| D2 | 4.15 | | 4.45 |
| D3 | 4.05 | 4.20 | 4.35 |
| D4 | 4.80 | 5.00 | 5.10 |
| D5 | 0.25 | 0.40 | 0.55 |
| D6 | 0.15 | 0.30 | 0.45 |
| D7 | 1.68 | | 1.98 |
| e | | 1.27 | |
| E | 6.20 | 6.40 | 6.60 |
| E2 | 3.50 | | 3.70 |
| E3 | 2.35 | | 2.55 |
| E4 | 0.40 | | 0.60 |
| E5 | 0.08 | | 0.28 |
| E6 | 0.20 | 0.325 | 0.45 |
| E7 | 0.85 | 1.00 | 1.15 |
| E8 | 0.55 | | 0.75 |
| E9 | 4.00 | 4.20 | 4.40 |
| E10 | 3.55 | 3.70 | 3.85 |
| L | 0.90 | 1.00 | 1.10 |
| L1 | 0.175 | 0.275 | 0.375 |
| K | 1.05 | | 1.35 |
| Θ | 0° | | 12° |

Figure 20: PowerFLAT™ 5x6 double island recommended footprint (dimensions are in mm)



4.2 Packing information

Figure 21: PowerFLAT™ 5x6 WF tape (dimensions are in mm)

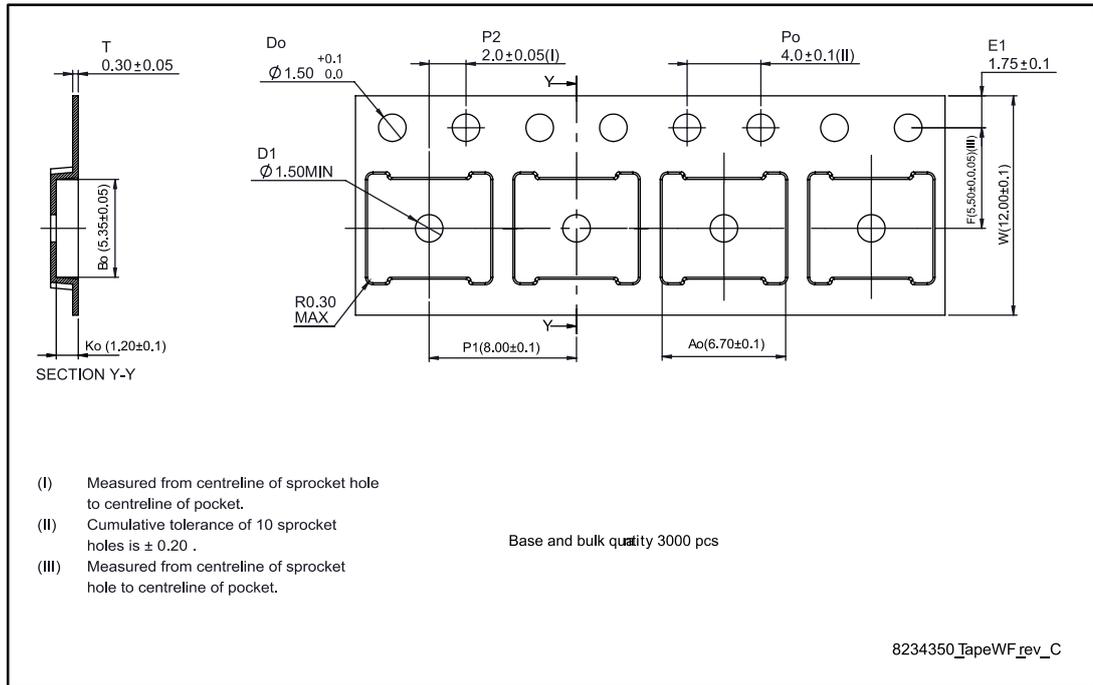


Figure 22: PowerFLAT™ 5x6 package orientation in carrier tape

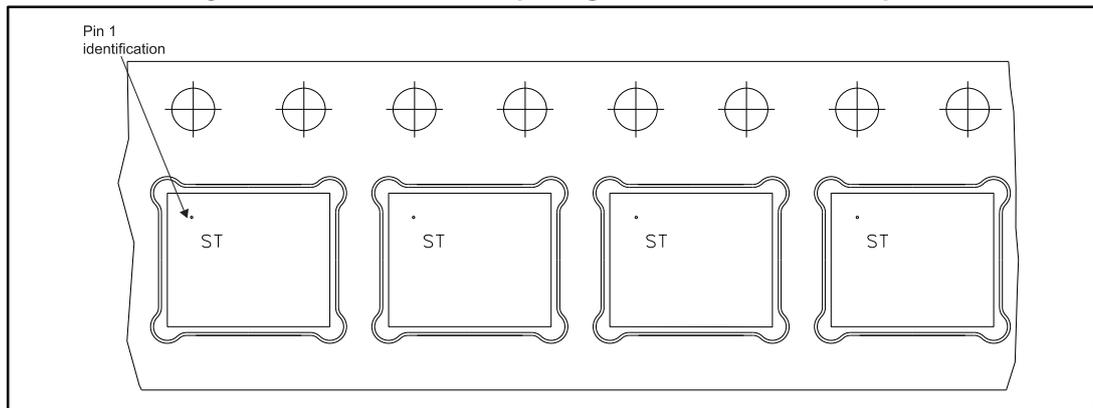
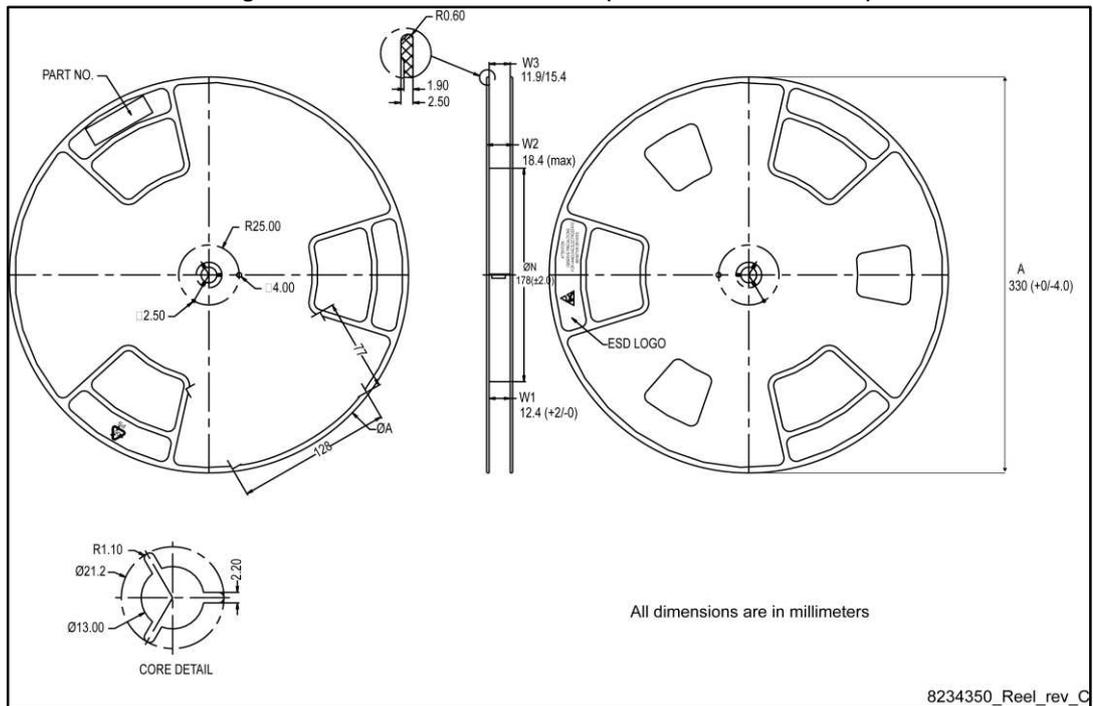


Figure 23: PowerFLAT™ 5x6 reel (dimensions are in mm)



5 Revision history

Table 10: Document revision history

| Date | Revision | Changes |
|-------------|----------|---|
| 02-Sep-2010 | 1 | First release. |
| 01-Jul-2014 | 2 | Updated: <i>Section 4: Package information</i> . Minor text changes |
| 13-Feb-2015 | 3 | Updated <i>Section 4: Package information</i> . Added <i>Section 5: Packaging information</i> |
| 06-Jul-2016 | 4 | Updated: <i>Section 6.1: "PowerFLAT 5x6 double island WF type C package information"</i> . Minor text changes. |

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